

<b>Notice of References Cited</b>	Application/Control No. 10/001,295	Applicant(s)/Patent Under Reexamination MIRIYALA ET AL.	
	Examiner Khai M Nguyen	Art Unit 2684	Page 1 of 1

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	B	US-6,549,768	04-2003	Fraccaroli, Federico	455/456.3
	C	US-5,519,706	05-1996	Bantz et al.	455/435.2
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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